# **MOSFET - N-Channel QFET**®

600 V, 0.3 A, 11.5  $\Omega$ 

## **FQN1N60C**

## Description

This N-Channel enhancement mode power MOSFET is produced using ON Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

#### **Features**

- 0.3 A, 600 V,  $R_{DS(on)} = 11.5 \Omega$  (Max.) @  $V_{GS} = 10$  V,  $I_D = 0.15 A$
- Low Gate Charge (Typ. 4.8 nC)
- Low Crss (Typ. 3.5 pF)
- 100% Avalanche Tested

## **ABSOLUTE MAXIMUM RATINGS** (T<sub>C</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Value	Unit	
V <sub>DSS</sub>	Drain to Source Voltage	600	V	
V <sub>GSS</sub>	Gate to Source Voltage	±30	V	
I <sub>D</sub>	Drain Current Continuous ( $T_C = 25^{\circ}C$ ) Continuous ( $T_C = 100^{\circ}C$ )		0.3 0.18	Α
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	1.2	Α
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	33	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	0.3	Α
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	0.3	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
P <sub>D</sub>	Power Dissipation $(T_A = 25^{\circ}C)$ $(T_L = 25^{\circ}C)$ Derate above 25°C		1 3 0.02	W W W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds		300	°C

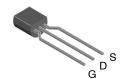
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. L = 59 mH,  $I_{AS}$  = 1.1 A,  $V_{DD}$  = 50 V,  $R_{G}$  = 25  $\Omega$ , Starting  $T_{J}$  = 25°C. 3.  $I_{SD} \le 0.3$  A, di/dt  $\le 200$  A/ $\mu$ s,  $V_{DD} \le BV_{DSS}$ , Starting  $T_{J}$  = 25°C.

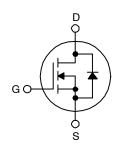


## ON Semiconductor®

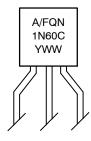
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TO-92 4.75x4.80 CASE 135AV



#### **MARKING DIAGRAM**



= Assembly Site FQN1N60C = Specific Device Code = Year of Production WW = Work Week Number

## **ORDERING INFORMATION**

Device	Package	Shipping
FQN1N60CTA	TO-92 3LD	2000 / Fan-Fold

## THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{ heta JL}$	Thermal Resistance, Junction-to-Lead, Max. (Note 5)	50	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction-to-Ambient, Max. (Note 6)	140	

## **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C, unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHAR	ACTERISTIC			•	•	•
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	600	-	-	V
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C	-	0.6	-	V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V	-	-	50	μΑ
		V <sub>DS</sub> = 480 V, T <sub>C</sub> = 125°C	-	-	250	1
I <sub>GSSF</sub>	Gate to Body Leakage Current, Forward	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V	-	-	100	nA
I <sub>GSSR</sub>	Gate to Body Leakage Current, Reverse	V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V	ı	-	-100	nA
ON CHARA	CTERISTICS					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.0	-	4.0	V
R <sub>DS(on)</sub>	Static Drain to Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 0.15 A	-	9.3	11.5	Ω
9FS	Forward Transconductance	V <sub>DS</sub> = 40 V, I <sub>D</sub> = 0.3 A	-	0.75	-	S
DYNAMIC	CHARACTERISTICS			•		
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz	_	130	170	pF
C <sub>oss</sub>	Output Capacitance	]	-	19	25	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	]	-	3.5	6	pF
SWITCHIN	G CHARACTERISTICS			-		
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD}$ = 300 V, $I_D$ = 1.1 A, $R_G$ = 25 $\Omega$	-	7	24	ns
t <sub>r</sub>	Turn-On Rise Time	(Note 4)	-	21	52	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	]	-	13	36	ns
t <sub>f</sub>	Turn-Off Fall Time	]	-	27	64	ns
Qg	Total Gate Charge	V <sub>DS</sub> = 480 V, I <sub>D</sub> = 1.1 A, V <sub>GS</sub> = 10 V	-	4.8	6.2	nC
$Q_{gs}$	Gate to Source Charge	(Note 4)	-	0.7	-	nC
$Q_{gd}$	Gate to Drain Charge	]	-	2.7	-	nC
DRAIN-SO	URCE DIODE CHARACTERISTICS AND M	IAXIMUM RATINGS				
I <sub>S</sub>	Maximum Continuous Drain to Source Diode Forward Current		-	-	0.3	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current		-	-	1.2	Α
V <sub>SD</sub>	Drain to Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 0.3 A	-	-	1.4	V
t <sub>rr</sub>	Reverse Recovery Time	$V_{GS} = 0 \text{ V, } I_S = 1.1 \text{ A, } dI_F/dt = 100 \text{ A/}\mu\text{s}$	_	190	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	1	_	0.53	-	μС

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- 4. Essentially independent of operating temperature.
- Reference point of the R<sub>θ,JL</sub> is the drain lead.
   When mounted on 3"x4.5" FR-4 PCB without any pad copper in a still air environment  $(R_{\theta JA})$  is the sum of the junction-to-case and case-to-ambient thermal resistance.  $R_{\theta CA}$  is determined by the user's board design)

### **TYPICAL CHARACTERISTICS**

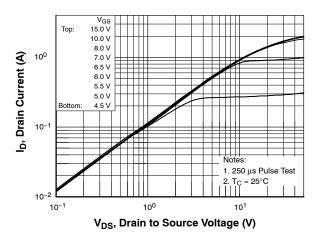


Figure 1. On-Region Characteristics

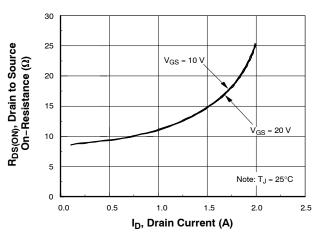


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

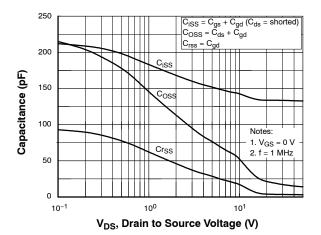


Figure 5. Capacitance Characteristics

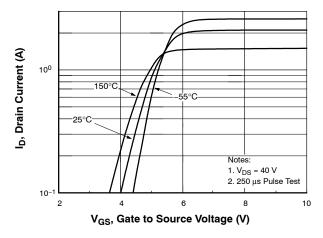


Figure 2. Transfer Characteristics

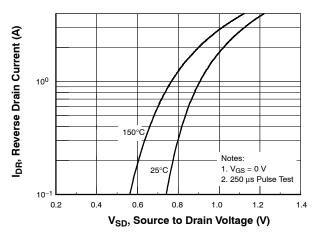


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

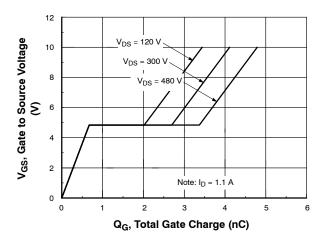


Figure 6. Gate Charge Characteristics

## TYPICAL CHARACTERISTICS (Continued)

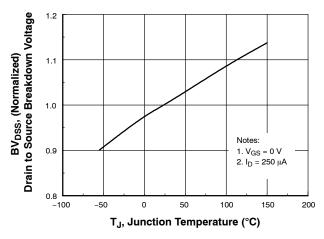


Figure 7. Breakdown Voltage Variation vs. Temperature

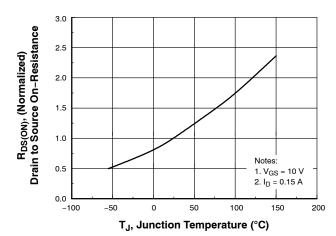


Figure 8. On–Resistance Variation vs. Temperature

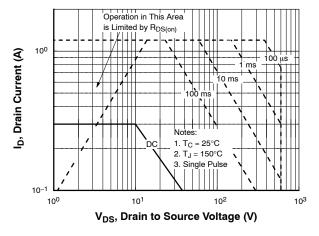


Figure 9. Maximum Safe Operating Area

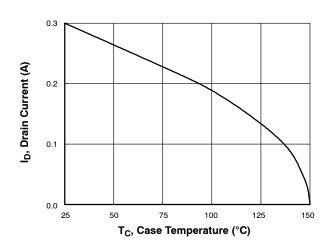


Figure 10. Maximum Drain Current vs. Case Temperature

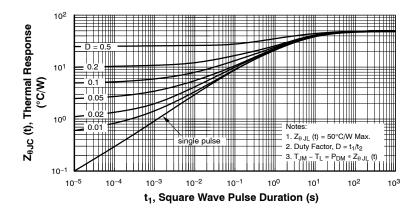


Figure 11. Transient Thermal Response Curve

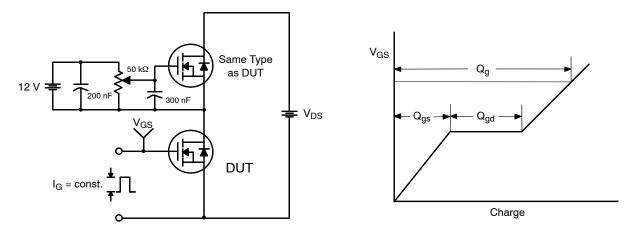


Figure 12. Gate Charge Test Circuit & Waveform

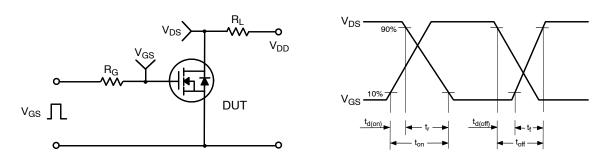


Figure 13. Resistive Switching Test Circuit & Waveforms

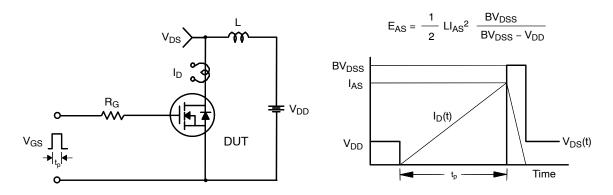
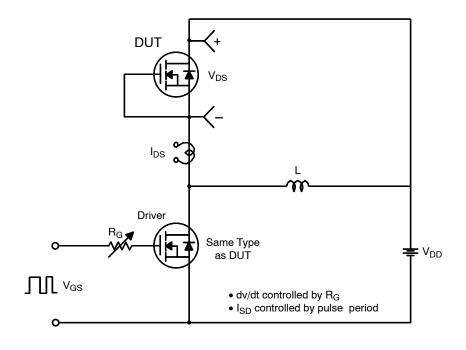


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



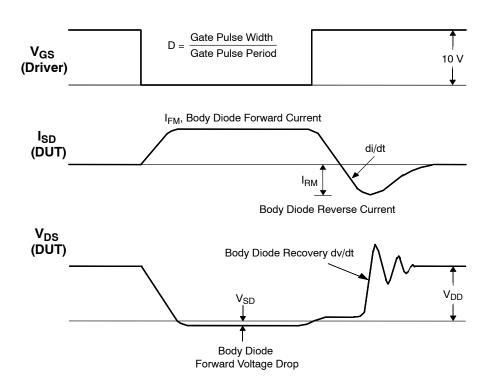


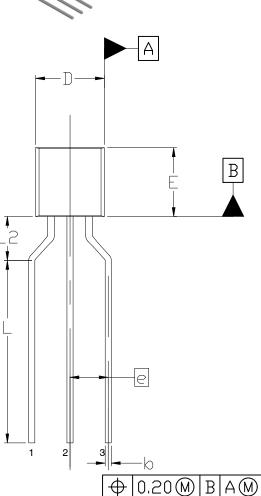
Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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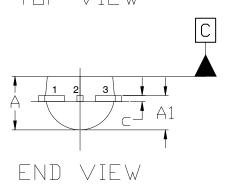
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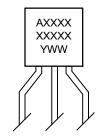
## NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, GATE REMAINS AND TIE BAR PROTRUSIONS.

	MILLIMETERS			
DIM	MIN.	N□M.	MAX.	
Α	3.05	3,60	4.19	
A1	2.13	2.50	2,88	
b	0.36	0,46	0.56	
С	0.30	0.40	0.52	
D	4.32	4.75	5,20	
E	4.32	4.80	5,33	
6	2.54 BSC			
L	10.50	11.75	13.00	
L2	2.54		3,44	



# GENERIC MARKING DIAGRAM\*



XXXX = Specific Device Code A = Assembly Location

Y = Year WW = Work Week

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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